

<b>Notice of References Cited</b>	Application/Control No. 10/698,578		Applicant(s)/Patent Under Reexamination KUREBAYASHI ET AL.	
	Examiner Thomas D. Alunkal		Art Unit 2627	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0123352	07-2003	Chen, Chien-Shou	369/47.53
*	B	US-6,563,775	05-2003	Sato, Shinichi	369/47.53
*	C	US-6,459,666	10-2002	Yokoi, Kenya	369/47.15
*	D	US-2002/0085470	07-2002	Yokoi, Kenya	369/59.11
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.